

## 20V N-Channel Enhancement Mode MOSFET

### Features

- 20V/0.95A,  $R_{DS(ON)}=380m\Omega@V_{GS}=4.5V$
- 20V/0.75A,  $R_{DS(ON)}=450m\Omega@V_{GS}=2.5V$
- 20V/0.65A,  $R_{DS(ON)}=800m\Omega@V_{GS}=1.8V$
- 20V/0.65A,  $R_{DS(ON)}=1000m\Omega@V_{GS}=1.5V$
- Low Offset (Error) Voltage
- Low-Voltage Operation
- High-Speed Circuits
- Low Battery Voltage Operation
- ESD Protected
- SOT-723 package design

### Product Description

LMN1072K, N-Channel enhancement mode MOSFET, uses Advanced Trench Technology

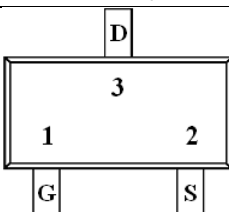
to provide excellent  $R_{DS(ON)}$ , low gate charge.

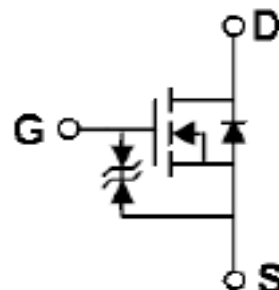
These devices are particularly suited for low voltage power management, such as smart phone and notebook computer, and low in-line power loss are needed in commercial industrial surface mount applications.

### Applications

- Power Management in Notebook
- Portable Equipment
- Battery Powered System
- DC/DC Converter
- Load Switch
- DSC
- LCD Display inverter

### Pin Configuration

LMN1072KAF (SOT-723)	
	
PIN	Description
1	Gate
2	Source
3	Drain



**Ordering Information**

Ordering Information					
Part Number	P/N	PKG code	Pb Free code	Package	Quantity
LMN1072KAF	LMN1072K	A	F	SOT-723	8000 PCS

**Marking Information**

Marking Information		
Part Marking	Part Number	LFC code
2XW	2	XW

**Absolute Maximum Ratings**

(T<sub>C</sub>=25°C Unless otherwise noted)

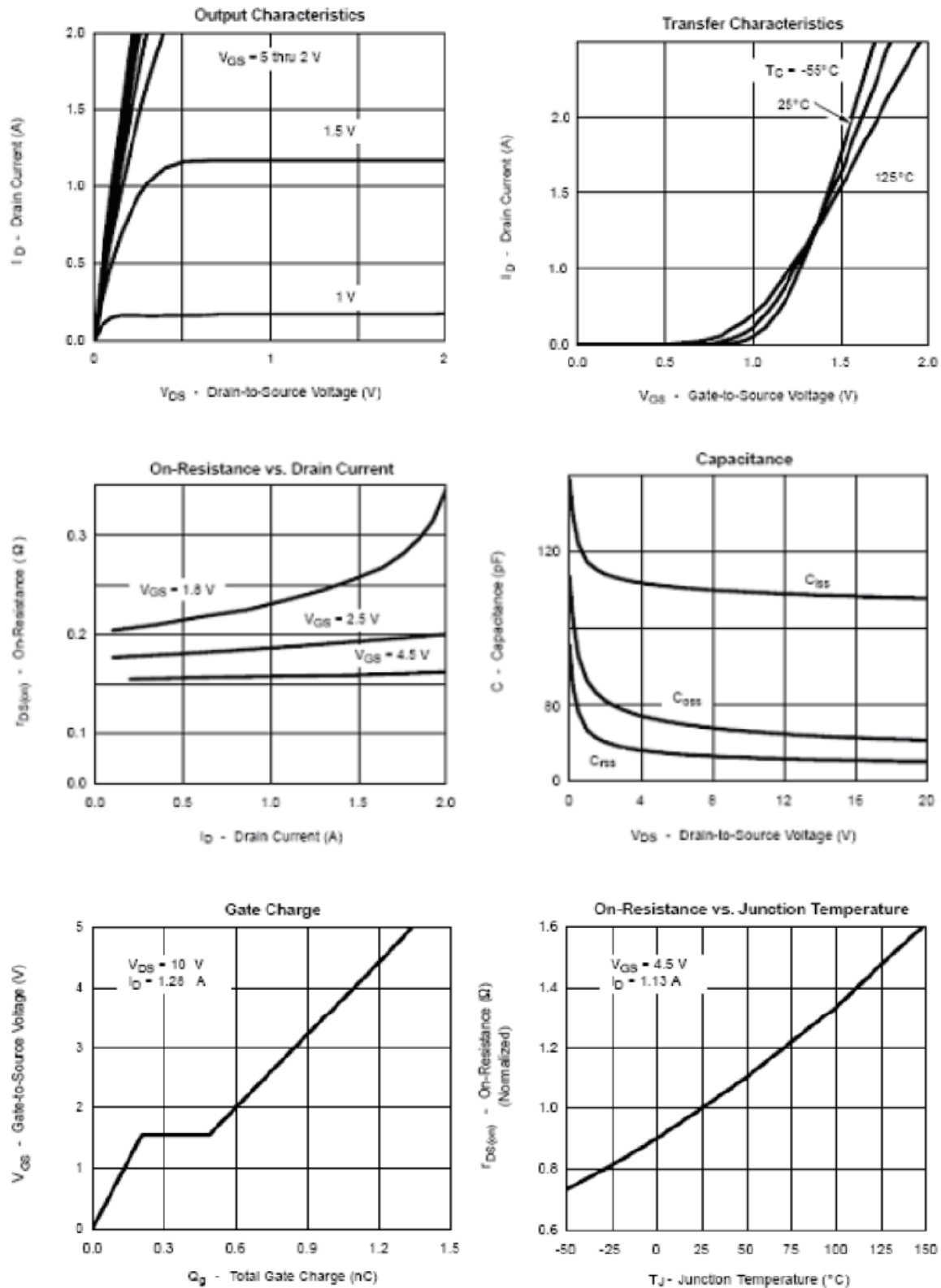
Symbol	Parameter	Typical	Unit
V <sub>DSS</sub>	Drain-Source Voltage	20	V
V <sub>GSS</sub>	Gate-Source Voltage	±12	V
I <sub>D</sub>	Continuous Drain Current (T <sub>J</sub> =150°C)	0.95	A
I <sub>DM</sub>	Pulsed Drain Current	4.0	A
I <sub>S</sub>	Continuous Source Current (Diode Conduction)	0.3	A
P <sub>D</sub>	Power Dissipation	0.15	W
T <sub>J</sub>	Operating Junction Temperature	-55 to +150	°C
T <sub>STG</sub>	Storage Temperature Range	-55 to +150	°C

**Electrical Characteristics**

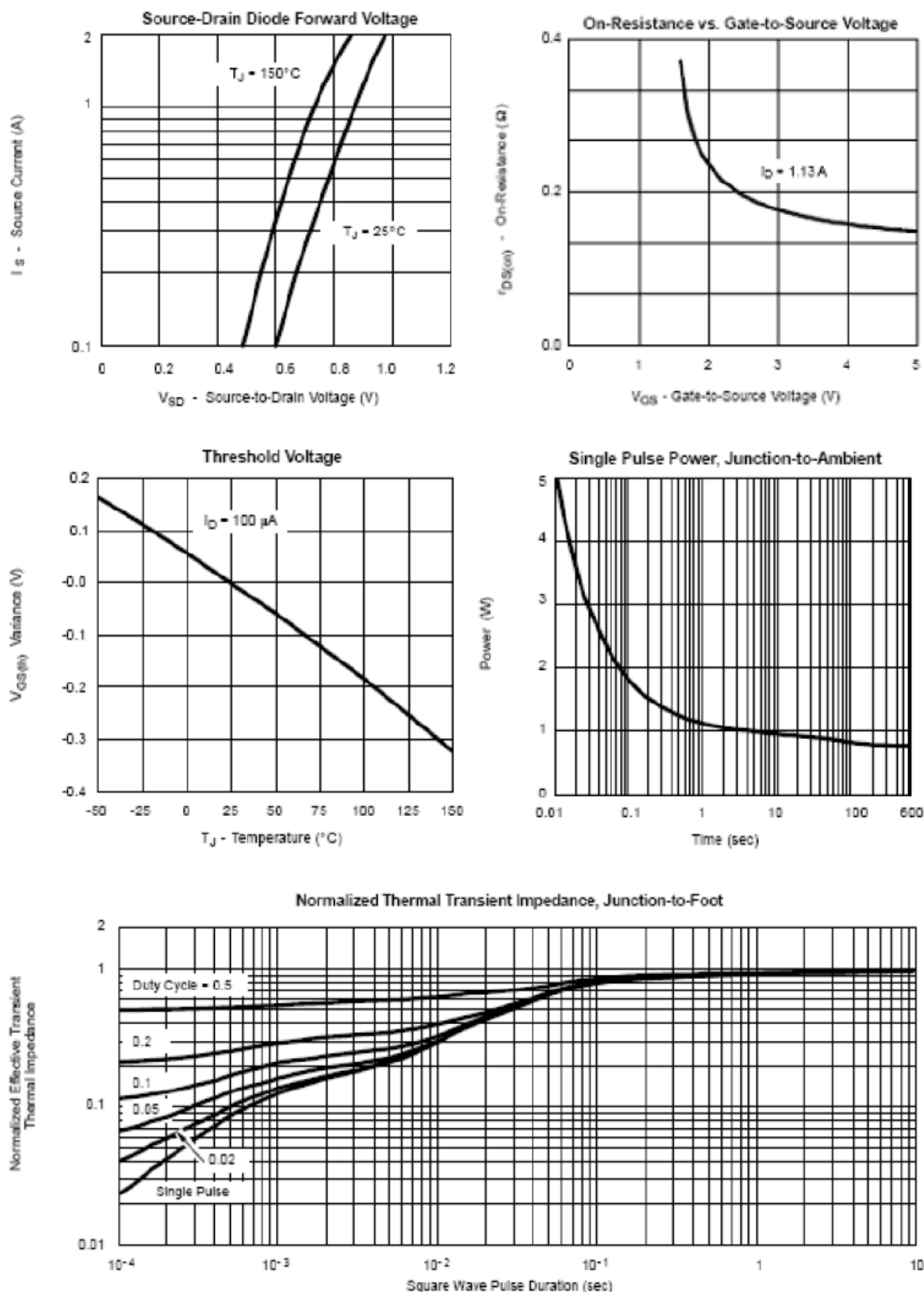
(T<sub>C</sub>=25°C Unless otherwise noted)

Symbol	Parameter	Conditions	Min	Typ	Max	Unit
Static						
V <sub>(BR)DSS</sub>	Drain-Source Breakdown Voltage	V <sub>GS</sub> =0V, I <sub>D</sub> =250uA	20			V
V <sub>GS(th)</sub>	Gate Threshold Voltage	V <sub>DS</sub> =V <sub>GS</sub> , ID=250uA	0.35		1	
I <sub>GSS</sub>	Gate Leakage Current	V <sub>DS</sub> =0V, V <sub>GS</sub> =±12V			30	uA
I <sub>DSS</sub>	Zero Gate Voltage Drain Current	V <sub>DS</sub> =20V, V <sub>GS</sub> =0V			1	uA
		V <sub>DS</sub> =20V, V <sub>GS</sub> =0V T <sub>J</sub> =55°C			5	
I <sub>D(ON)</sub>	On-State Drain Current	V <sub>DS</sub> ≥4.5V, V <sub>GS</sub> =5V	0.7			A
R <sub>DS(on)</sub>	Drain-Source On-Resistance	V <sub>GS</sub> =4.5V, ID=0.95A		260	380	mΩ
		V <sub>GS</sub> =2.5V, ID=0.75A		320	450	
		V <sub>GS</sub> =1.8V, ID=0.65A		420	800	
		V <sub>GS</sub> =1.5V, ID=0.65A		500	1000	
g <sub>FS</sub>	Forward Transconductance	V <sub>DS</sub> =10V, ID=0.4A		1		S
V <sub>SD</sub>	Diode Forward Voltage	I <sub>S</sub> =0.15A, V <sub>GS</sub> =0V		0.8	1.2	V
Dynamic						
Q <sub>g</sub>	Total Gate Charge	V <sub>DS</sub> =10V, V <sub>GS</sub> =4.5V, I <sub>D</sub> =0.5A		1	2	nC
Q <sub>gs</sub>	Gate-Source Charge			0.26		
Q <sub>gd</sub>	Gate-Drain Charge			0.2		
C <sub>iSS</sub>	Input Capacitance	V <sub>DS</sub> =10V, V <sub>GS</sub> =0V, f=1MHz		38.2	75	pF
C <sub>oSS</sub>	Output Capacitance			14.4	28	
C <sub>rSS</sub>	Reverse Transfer Capacitance			6	12	
t <sub>d(on)</sub>	Turn-On Time	V <sub>DD</sub> =10V, R <sub>L</sub> =10Ω, I <sub>D</sub> =0.5A, V <sub>GS</sub> =4.5V, R <sub>G</sub> =10Ω		5	10	ns
t <sub>r</sub>				3.5	7	
t <sub>d(off)</sub>	Turn-Off Time			14	28	
t <sub>f</sub>				6	12	

# Typical Performance Characteristics

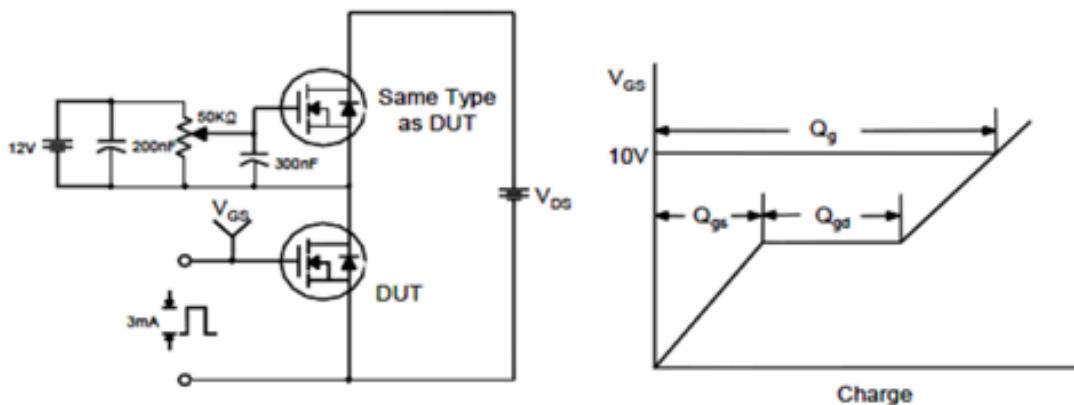


# Typical Performance Characteristics(continue)

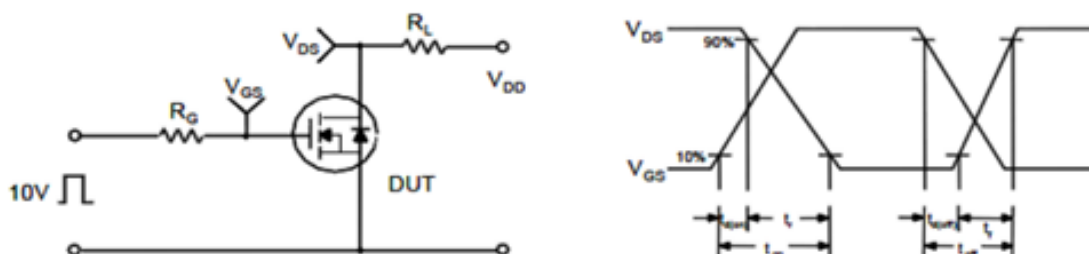


# Typical Performance Characteristics(continue)

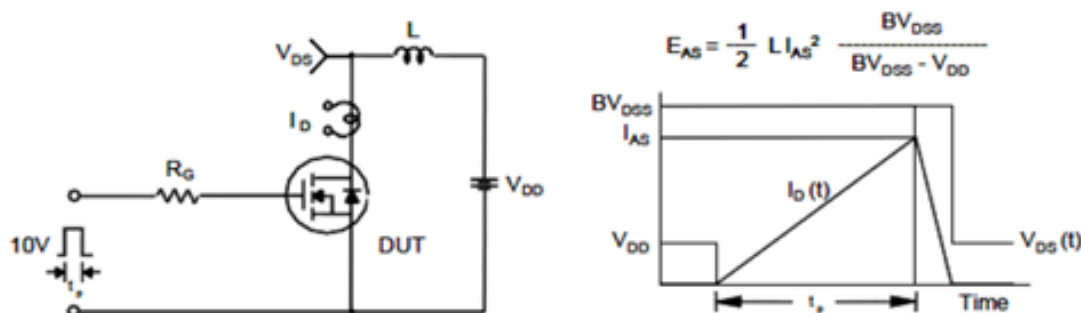
Gate Charge Test Circuit & Waveform

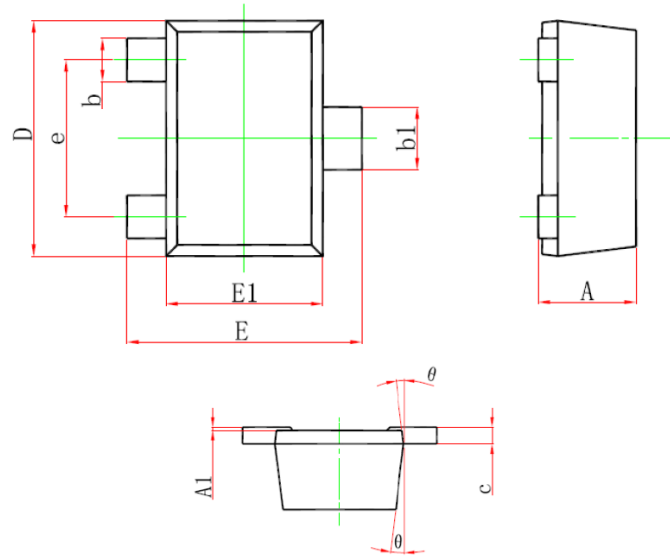


Resistive Switching Test Circuit & Waveforms



Unclamped Inductive Switching Test Circuit & Waveforms



**Package Dimension:**
**SOT-723**


Dimensions				
Symbol	Millimeters		Inches	
	Min	Max	Min	Max
<b>A</b>	-	0.500	-	0.020
<b>A1</b>	0.000	0.050	0.000	0.002
<b>b</b>	0.170	0.270	0.007	0.011
<b>b1</b>	0.270	0.370	0.011	0.015
<b>c</b>	-	0.150	-	0.008
<b>D</b>	1.150	1.250	0.045	0.049
<b>E</b>	1.150	1.250	0.045	0.049
<b>E1</b>	0.750	0.850	0.030	0.033
<b>e</b>	0.800TYP		0.031TYP	
<b><math>\theta</math></b>	7°REF		7°REF	

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